

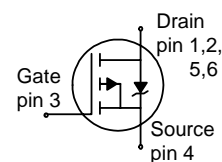
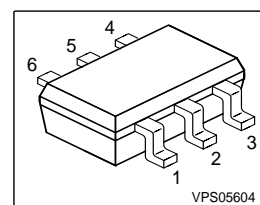
OptiMOS[®]-P Small-Signal-Transistor Feature

- P-Channel
- Enhancement mode
- Super Logic Level (2.5 V rated)
- 150°C operating temperature
- Avalanche rated
- dv/dt rated
- Pb-free lead plating; RoHS compliant
- Qualified according to AEC Q101
- Halogen-free according to IEC61249-2-21


Product Summary

V_{DS}	-20	V
$R_{DS(on)}$	175	m Ω
I_D	-1.5	A

PG-SOT-363



Type	Package	Tape and Reel inf	Marking
BSV 236SP	PG-SOT-363	H6327:3000pcs/r.	X2s

Maximum Ratings, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_A=25^\circ\text{C}$ $T_A=70^\circ\text{C}$	I_D	-1.5 -1.2	A
Pulsed drain current $T_A=25^\circ\text{C}$	$I_{D\text{ puls}}$	-6	
Avalanche energy, single pulse $I_D=-1.5\text{ A}$, $V_{DD}=-10\text{V}$, $R_{GS}=25\Omega$	E_{AS}	9.5	mJ
Reverse diode dv/dt $I_S=-1.5\text{A}$, $V_{DS}=-16\text{V}$, $di/dt=200\text{A}/\mu\text{s}$, $T_{j\text{max}}=150^\circ\text{C}$	dv/dt	-6	kV/ μs
Gate source voltage	V_{GS}	± 12	V
Power dissipation $T_A=25^\circ\text{C}$	P_{tot}	0.56	W
Operating and storage temperature	T_j, T_{stg}	-55... +150	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1		55/150/56	
ESD Class JESD22-A114-HBM		Class 0	

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - soldering point	R_{thJS}	-	-	90	K/W
SMD version, device on PCB:	R_{thJA}				
@ min. footprint		-	-	220	
@ 6 cm ² cooling area ¹⁾		-	-	110	

Electrical Characteristics, at $T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain-source breakdown voltage $V_{GS}=0, I_D=-250\mu A$	$V_{(BR)DSS}$	-20	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=-8\mu A$	$V_{GS(th)}$	-0.6	-0.9	-1.2	
Zero gate voltage drain current $V_{DS}=-20V, V_{GS}=0, T_j=25\text{ °C}$ $V_{DS}=-20V, V_{GS}=0, T_j=150\text{ °C}$	I_{DSS}	-	-0.1	-1	μA
Gate-source leakage current $V_{GS}=-12V, V_{DS}=0$	I_{GSS}	-	-10	-100	
Drain-source on-state resistance $V_{GS}=-2.5V, I_D=-0.8A$	$R_{DS(on)}$	-	193	285	m Ω
Drain-source on-state resistance $V_{GS}=-4.5, I_D=-1.5A$	$R_{DS(on)}$	-	131	175	

¹⁾Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical without blown air; $t \leq 10$ sec.

Electrical Characteristics, at $T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic Characteristics

Transconductance	g_{fs}	$ V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ $I_D = -1.2A$	2.2	4.4	-	S
Input capacitance	C_{iss}	$V_{GS} = 0, V_{DS} = -15V,$ $f = 1MHz$	-	228	-	pF
Output capacitance	C_{oss}		-	92	-	
Reverse transfer capacitance	C_{rss}		-	75	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = -10V, V_{GS} = -4.5V,$ $I_D = -1A, R_G = 6\Omega$	-	5.7	8.5	ns
Rise time	t_r		-	8.5	12.7	
Turn-off delay time	$t_{d(off)}$		-	14.1	21.1	
Fall time	t_f		-	12.2	18.3	

Gate Charge Characteristics

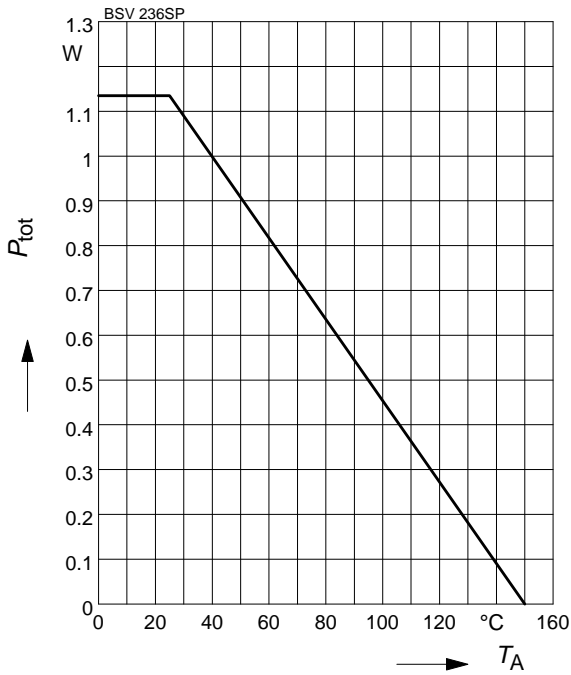
Gate to source charge	Q_{gs}	$V_{DD} = -10V, I_D = -1.5A$	-	-0.4	-0.6	nC
Gate to drain charge	Q_{gd}		-	-1.8	-2.7	
Gate charge total	Q_g	$V_{DD} = -10V, I_D = -1.5A,$ $V_{GS} = 0 \text{ to } -4.5V$	-	-3.8	-5.7	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = -10V, I_D = -1.5A$	-	-1.6	-	V

Reverse Diode

Inverse diode continuous forward current	I_S	$T_A = 25\text{ °C}$	-	-	-0.11	A
Inverse diode direct current, pulsed	I_{SM}		-	-	-6	
Inverse diode forward voltage	V_{SD}	$V_{GS} = 0, I_F = I_D $	-	0.88	1.3	V
Reverse recovery time	t_{rr}	$V_R = -10V, I_F = I_D ,$ $dI_F/dt = 100A/\mu s$	-	16.4	20.5	ns
Reverse recovery charge	Q_{rr}		-	3.4	4.3	nC

1 Power dissipation

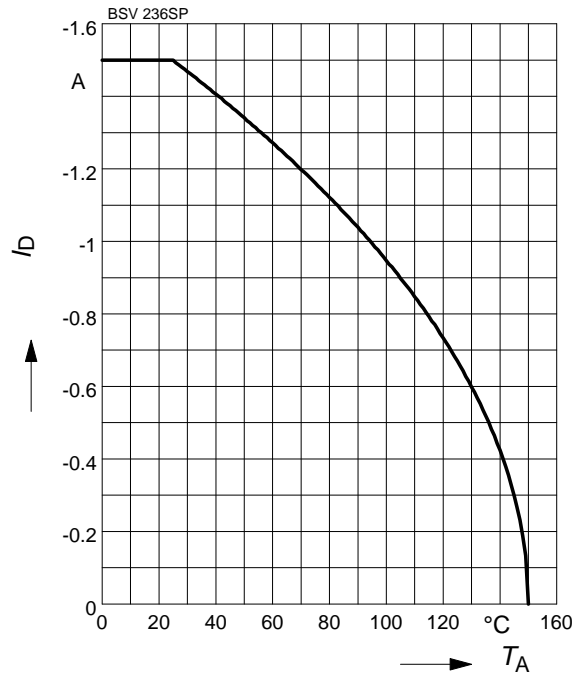
$$P_{\text{tot}} = f(T_A)$$



2 Drain current

$$I_D = f(T_A)$$

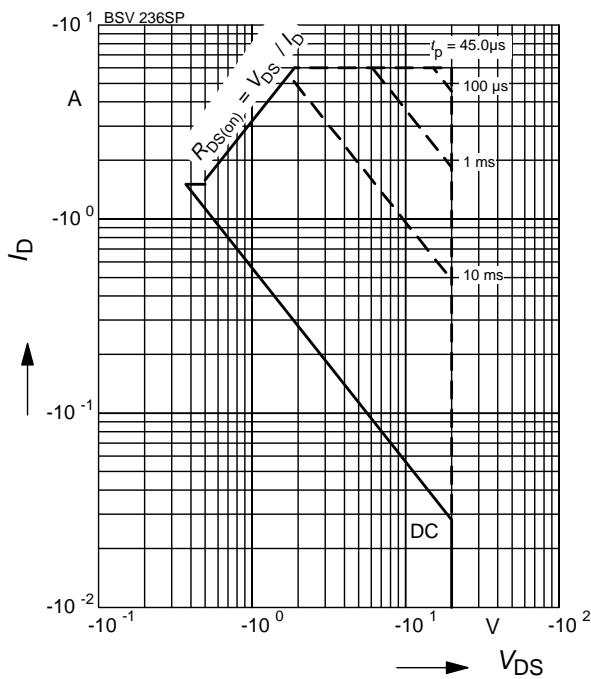
parameter: $|V_{GS}| \geq 4.5 \text{ V}$



3 Safe operating area

$$I_D = f(V_{DS})$$

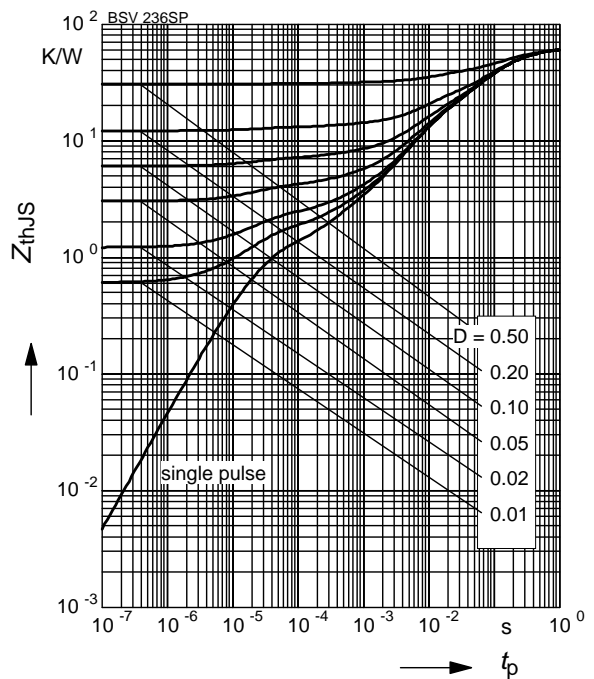
parameter: $D = 0, T_A = 25 \text{ °C}$



4 Transient thermal impedance

$$Z_{\text{thJS}} = f(t_p)$$

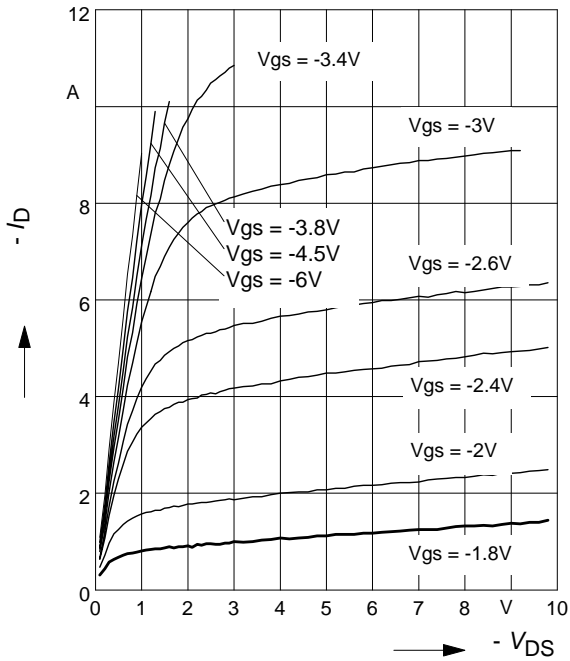
parameter: $D = t_p/T$



5 Typ. output characteristic

$I_D = f(V_{DS}); T_j=25^\circ\text{C}$

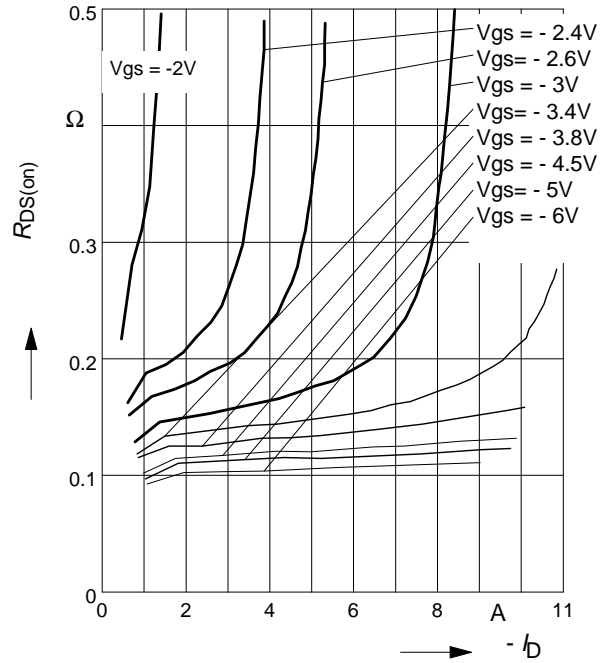
parameter: $t_p = 80 \mu\text{s}$



6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D)$

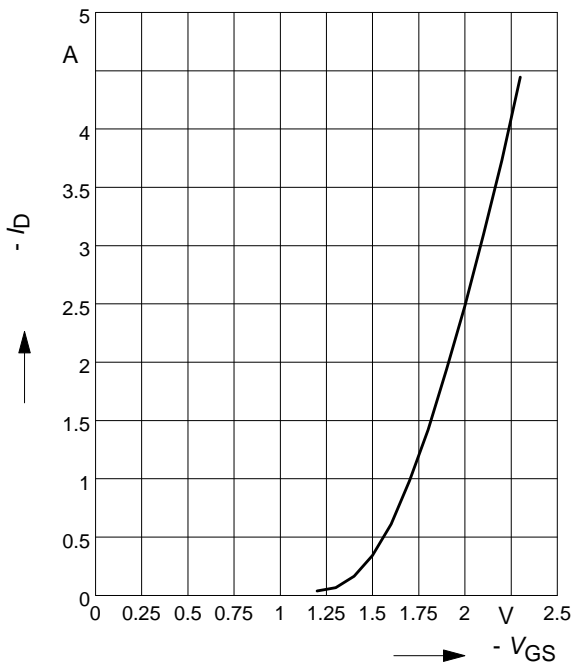
parameter: V_{GS}



7 Typ. transfer characteristics

$I_D = f(V_{GS}); |V_{DS}| \geq 2 \times |I_D| \times R_{DS(on)max}$

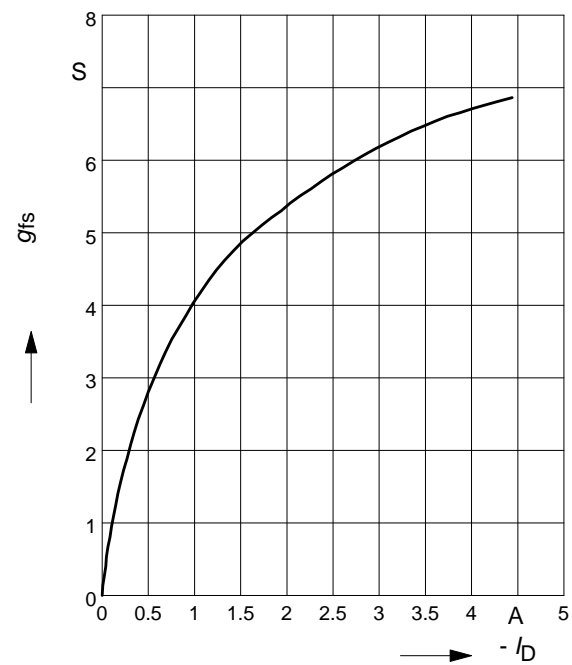
parameter: $t_p = 80 \mu\text{s}$



8 Typ. forward transconductance

$g_{fs} = f(I_D); T_j=25^\circ\text{C}$

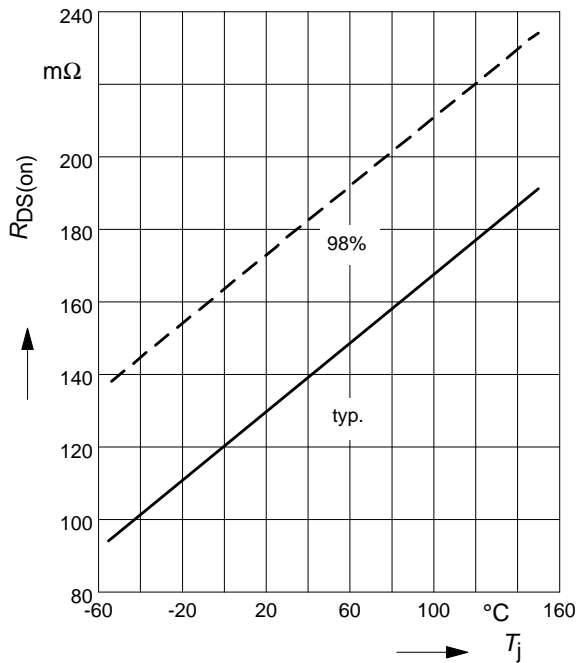
parameter: $t_p = 80 \mu\text{s}$



9 Drain-source on-resistance

$$R_{DS(on)} = f(T_j)$$

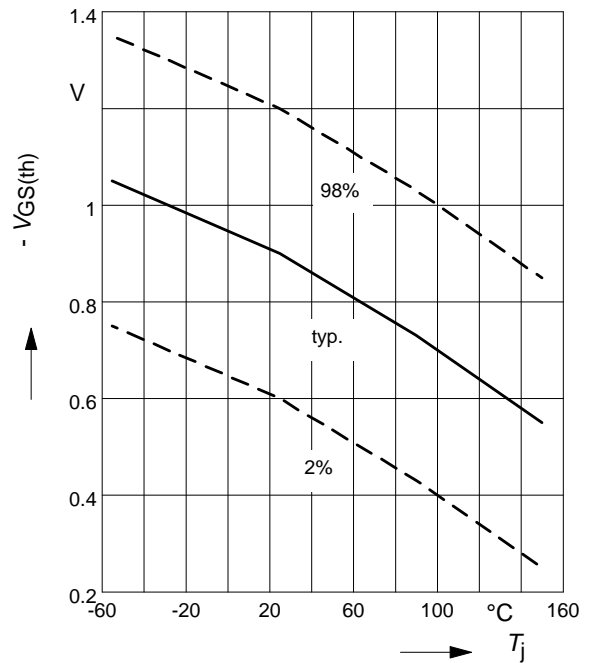
parameter: $I_D = -1.5 \text{ A}$, $V_{GS} = -4.5 \text{ V}$



10 Gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

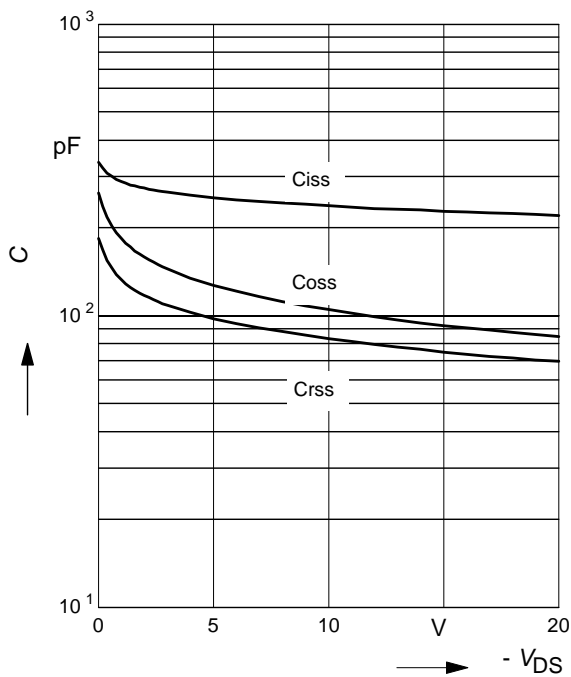
parameter: $V_{GS} = V_{DS}$, $I_D = -8 \mu\text{A}$



11 Typ. capacitances

$$C = f(V_{DS})$$

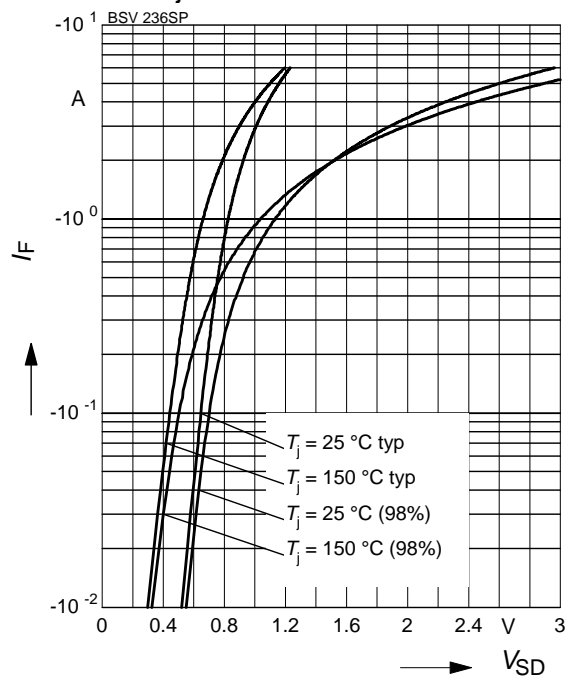
parameter: $V_{GS}=0$, $f=1 \text{ MHz}$



12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

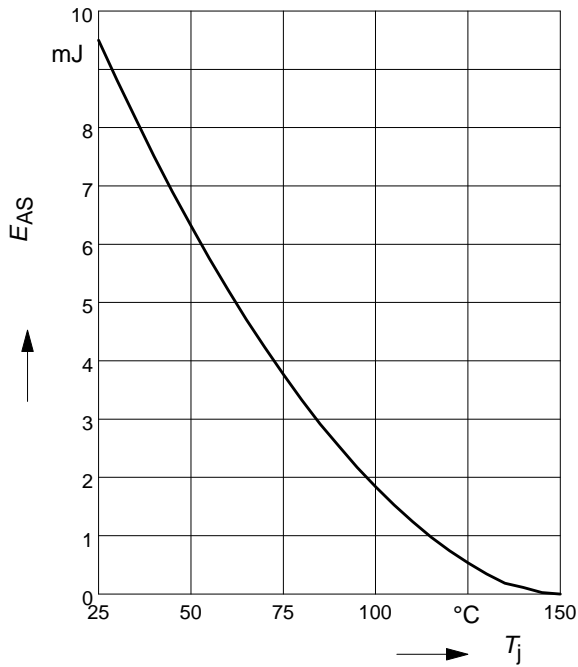
parameter: T_j , $t_p = 80 \mu\text{s}$



13 Typ. avalanche energy

$E_{AS} = f(T_j)$, par.: $I_D = -1.5\text{ A}$

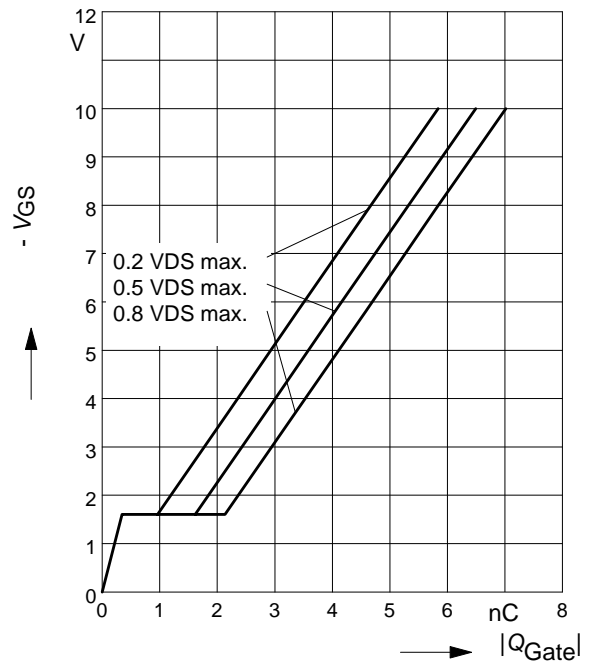
$V_{DD} = -10\text{ V}$, $R_{GS} = 25\ \Omega$



14 Typ. gate charge

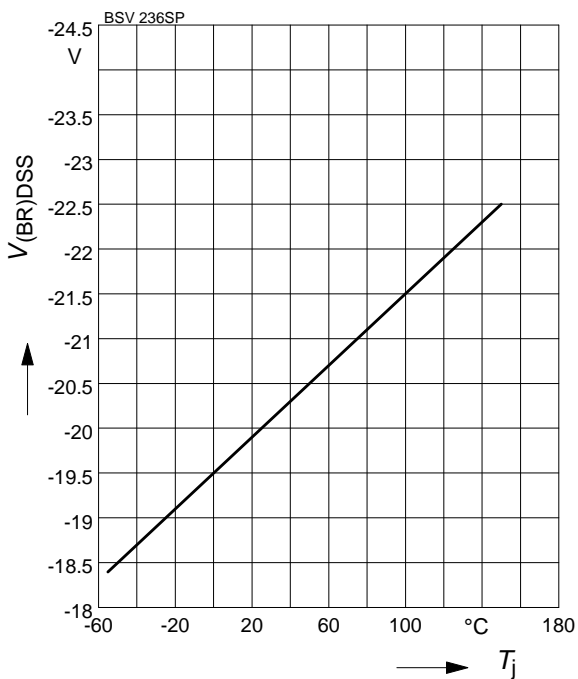
$|V_{GS}| = f(Q_{Gate})$

parameter: $I_D = -1.5\text{ A}$ pulsed



15 Drain-source breakdown voltage

$V_{(BR)DSS} = f(T_j)$



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